

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ADAPATHYA ET AL.	
		Examiner Tom V. Sheng	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0212988	10-2004	Fuwausa, Michelle Jillian	362/103
*	C	US-2005/0063199	03-2005	Levy et al.	362/565
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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